

**Search Notes**

Application/Control No.

10/531,230

Examiner

Mohamed Charioui

Applicant(s)/Patent under  
Reexamination

OHTANI, HITOSHI

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	68, 80, 91, 94, , 95, 97, 149	12/19/2006	MC
702	150, 151	12/19/2006	MC
702	152-155	12/19/2006	MC
702	159, 163	12/19/2006	MC
356	4.01	12/19/2006	MC
356	4.03	12/19/2006	MC
356	22	12/19/2006	MC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: ((image\$1 or two\$dimension\$3 or "2-dimension" or "2-dimensional" or "2 dimension" or "2 dimensions" or "2 dimensional	12/19/2006	MC
") with (position\$1 or coorodonat\$3) with (three\$dimension\$3 or "3- dimension" or "3-dimensional" or "3 dimension" or	12/19/2006	MC
"3 dimensions" or "3 dimensional")) and collimat\$6	12/19/2006	MC
East: image \$dimension\$3 and (position or coorodonat\$6) and (collimat\$6 with measur\$6 with angle\$1)	12/19/2006	MC